

# Industrial Current/Voltage Output Driver with Programmable Ranges

# AD5750

#### FEATURES

Current output ranges: 4 mA to 20 mA, 0 mA to 20 mA or 0 mA to 24 mA, ±20 mA, and ±24 mA ±0.03% FSR total unadjusted error (TUE) ±5 ppm/°C typical output drift Voltage output ranges: 0 V to 5 V, 0 V to 10 V, ±5 V, and ±10 V, with 20% overrange ±0.02% FSR total unadjusted error (TUE) ±3 ppm/°C output drift Flexible serial digital interface **On-chip output fault detection** PEC error checking **Asynchronous CLEAR function** Flexible power-up condition to 0 V or tristate Power supply range AVDD: +12 V (± 10%) to +24 V (± 10%) AVSS: -12 V (± 10%) to -24 V (± 10%) Output loop compliance to AV<sub>DD</sub> – 2.75 V Temperature range: -40°C to +105°C 32-lead 5 mm × 5 mm LFCSP package

#### **APPLICATIONS**

Process control Actuator control PLCs

#### **GENERAL DESCRIPTION**

The AD5750 is a single-channel, low cost, precision, voltage/ current output driver with hardware or software programmable output ranges. The software ranges are configured via an SPI-/ MICROWIRE<sup>™</sup>-compatible serial interface. The AD5750 targets applications in PLC and industrial process control. The analog input to the AD5750 is provided from a low voltage, single-supply, digital-to-analog converter (DAC) and is internally conditioned to provide the desired output current/voltage range. The analog input range is 0 V to 4.096 V. The output current range is programmable across five current ranges: 4 mA to 20 mA, 0 mA to 20 mA or 0 mA to 24 mA,  $\pm 20$  mA, and  $\pm 24$  mA.

Voltage output is provided from a separate pin that can be configured to provide 0 V to 5 V, 0 V to 10 V,  $\pm$ 5 V, or  $\pm$ 10 V output ranges. An overrange of 20% is available on the voltage ranges.

Analog outputs are short-circuit and open-circuit protected and can drive capacitive loads of 1  $\mu$ F and inductive loads of 0.1 H.

The device is specified to operate with a power supply range from  $\pm 12$  V to  $\pm 24$  V. Output loop compliance is 0 V to AV<sub>DD</sub> – 2.75 V.

The flexible serial interface is SPI and MICROWIRE compatible and can be operated in 3-wire mode to minimize the digital isolation required in isolated applications. The interface also features an optional PEC error checking feature using CRC-8 error checking, useful in industrial environments where data communication corruption can occur.

The device also includes a power-on-reset function ensuring that the device powers up in a known state (0 V or tristate), and an asynchronous CLEAR pin that sets the outputs to zero scale/midscale voltage output or the low end of the selected current range.

A HW SELECT pin is used to configure the part for hardware or software mode on power-up.

#### Table 1. Related Device

Part Number	Description
AD5422	Single-channel, 16-bit, serial input current source and voltage output DAC

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#### **REVISION HISTORY**

7/09—Revision 0: Initial Version

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### FUNCTIONAL BLOCK DIAGRAM

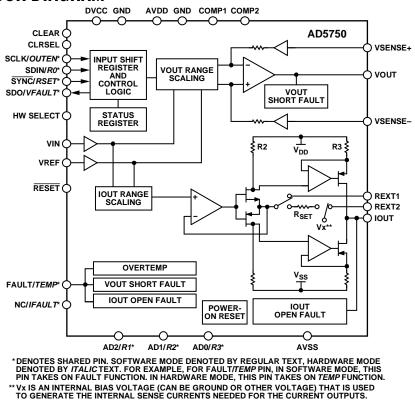


Figure 1.

### SPECIFICATIONS

AVDD/AVSS =  $\pm 12 \text{ V} (\pm 10\%)$  to  $\pm 24 \text{ V} (\pm 10\%)$ , DVCC = 2.7 V to 5.5 V, GND = 0 V. IOUT: R<sub>LOAD</sub> = 300  $\Omega$ . All specifications T<sub>MIN</sub> to T<sub>MAX</sub>, unless otherwise noted.

#### Table 2.

Parameter <sup>1</sup>	Min	Тур	Max	Unit	Test Conditions/Comments
INPUT VOLTAGE RANGE					Output unloaded
		0 to 4.096		V	
Input Leakage Current	-1		+1	μΑ	
REFERENCE INPUT					
Reference Input Voltage		4.096		V	External reference needs to be exactly as stated; otherwise, accuracy errors show up as error in output
Input Leakage Current	-1		+1	μA	
VOLTAGE OUTPUT					
Output Voltage Ranges	0		5	V	
	0		10	V	AVDD needs to have minimum 1.1 V headroom or >11.1 V
	-5		+5	V	
	-10		+10	V	AVDD/AVSS needs to have minimum 1.1 V headroom or >±11.1 V
Output Voltage Overranges	0		6	V	Programmable overranges; see the Detailed Description of Features section
	0		12	V	
	-6		+6	V	
	-12		+12	V	
	-2.5		+2.5	V	
Accuracy					
Total Unadjusted Error (TUE)					
B Version	-0.1		+0.1	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.05	±0.02	+0.05	% FSR	$T_A = 25^{\circ}C$
A Version	-0.3		+0.3	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.1	±0.05	+0.1	% FSR	$T_A = 25^{\circ}C$
Relative Accuracy (INL)	-0.02	±0.005	+0.02	% FSR	
Bipolar Zero Error (Offset at Midscale)	-10		+10	mV	±10 V range
	-8	±0.5	+8	mV	$T_A = 25^{\circ}C, \pm 10 \text{ V} \text{ range}$
	-5		+5	mV	±5 V range
	-4	±0.3	+4	mV	$T_A = 25^{\circ}C, \pm 5 V range$
Bipolar Zero Error TC <sup>2</sup>		±1.5		ppm FSR/°C	All bipolar ranges
Zero-Scale Error	-10		+10	mV	±10 V range
	-8	±0.5	+8	mV	$T_{A} = 25^{\circ}C, \pm 10 \text{ V range}$
	-5		+5	mV	± 5 V range
	-4	±0.3	+4	mV	$T_A = 25^{\circ}C, \pm 5 V range$
Zero-Scale Error TC <sup>2</sup>		±1		ppm FSR/°C	All bipolar ranges
Zero-Scale/Offset Error	-5		+5	mV	0 V to 10 V range
	-4	±0.5	+4	mV	$T_{A} = 25^{\circ}C, 0 V \text{ to } 10 V \text{ range}$
	-3		+3	mV	0 V to 5 V range
	-2.2	±0.3	+2.2	mV	$T_A = 25^{\circ}C$ , 0 V to 5 V range
Offset Error TC <sup>2</sup>		±2		ppm FSR/°C	All unipolar ranges
Gain Error	-0.05		+0.05	% FSR	All bipolar/unipolar ranges
	-0.04	±0.015	+0.04	% FSR	$T_A = 25^{\circ}C$
Gain Error TC <sup>2</sup>		±0.5		ppm FSR/°C	

Parameter <sup>1</sup>	Min	Тур	Max	Unit	<b>Test Conditions/Comments</b>
Full-Scale Error	-0.05		+0.05	% FSR	All bipolar/unipolar ranges
	-0.04	±0.015	+0.04	% FSR	$T_A = 25^{\circ}C$
Full-Scale Error TC <sup>2</sup>		±1.5		ppm FSR/°C	
/OLTAGE OUTPUT CHARACTERISTICS <sup>2</sup>					
Headroom			1.3	V	Output unloaded
Short-Circuit Current		15		mA	
Load	1			kΩ	
Capacitive Load Stability					$T_A = 25^{\circ}C$
$R_{LOAD} = \infty$			1	nF	
$R_{LOAD} = 2 k\Omega$			1	nF	
$R_{\text{load}} = \infty$			2	μF	External compensation capacitor required see the Driving Inductive Loads section
DC Output Impedance		0.12		Ω	
0 V to 5 V range, ¼ to ¾ Step		7		μs	Specified with 2 k $\Omega \parallel$ 220 pF, ±0.05%
0 V to 5 V range, 40 mV Input Step		4.5		μs	Specified with $2 \text{ k}\Omega \parallel 220 \text{ pF}, \pm 0.05\%$
Slew Rate		2		V/µs	Specified with 2 k $\Omega \parallel 220 \text{ pF}$
Output Noise		2.5		μV rms	0.1 Hz to 10 Hz bandwidth
ouputrioise		45.5		μV rms	100 kHz bandwidth
Output Noise Spectral Density		165		nV/√Hz	Measured at 10 kHz; specified with $2 \text{ k}\Omega \parallel 220 \text{ pF}$
AC PSRR		-65		dB	200 mV, 50 Hz/60 Hz sine wave superimposed on power supply voltage
DC PSRR		10		μ٧/٧	Outputs unloaded
URRENT OUTPUT					
Output Current Ranges	0		24	mA	
	0		20	mA	
	4		20	mA	
	-20		+20	mA	
	-24		+24	mA	
Output Current Overranges	0		24.5	mA	See the Detailed Description of Feature section
	0		20.4	mA	See the Detailed Description of Feature section
	4		20.4	mA	See the Detailed Description of Feature section
Accuracy, Internal R <sub>SET</sub>					
Total Unadjusted Error (TUE)					
B Version	-0.2		+0.2	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.08	±0.03	+0.08	% FSR	$T_A = 25^{\circ}C$
A Version	-0.5		+0.5	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.3	±0.15	+0.3	% FSR	$T_A = 25^{\circ}C$
Relative Accuracy (INL)	-0.02	±0.01	+0.02	% FSR	Unipolar ranges
······································	-0.03	±0.015	+0.03	% FSR	Bipolar ranges
Offset Error	-16	_0.010	+16	μA	4 mA to 20 mA, 0 mA to 20 mA, 0 mA to 24 mA ranges
	-10	+5	+10	μA	$T_A = 25^{\circ}C$
	-50		+50	μΑ	$\pm 20$ mA, $\pm 24$ mA ranges
	-26	+8	+30	μΑ	$T_A = 25^{\circ}C$
Offset Error TC <sup>2</sup>	20	+8 ±3	120	ppm FSR/°C	All ranges
Bipolar Zero Error	-35	<u> </u>	+35	μΑ	$\pm 20 \text{ mA}, \pm 24 \text{ mA ranges}$
	-35	+15	+33	μΑ	$\pm 20$ mA, $\pm 24$ mA ranges T <sub>A</sub> = 25°C

Parameter <sup>1</sup>	Min	Тур	Max	Unit	Test Conditions/Comments
Gain Error	-0.2		+0.2	% FSR	4 mA to 20 mA, 0 mA to 20 mA, 0 mA to 24 mA ranges
	-0.25		+0.25	% FSR	$\pm 20 \text{ mA}, \pm 24 \text{ mA ranges}$
	-0.03	±0.006	+0.03	% FSR	$T_A = 25^{\circ}C$
Gain TC <sup>2</sup>	0.05	±8	10.05	ppm FSR/°C	All ranges
Full-Scale Error	-0.2	10	+0.2	% FSR	All ranges
Full-Scale EITO	-0.2	±0.02	+0.2	% FSR	$T_A = 25^{\circ}C$
Full-Scale TC <sup>2</sup>	-0.125		+0.125	ppm FSR/°C	
		±4		ррпг г эк/ С	All ranges
Accuracy, External R <sub>SET</sub>					
Total Unadjusted Error (TUE)	0.1		. 0.1	0/ FCD	
B Version	-0.1		+0.1	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.08	±0.03	+0.08	% FSR	$T_A = 25^{\circ}$
A Version	-0.3		+0.3	% FSR	Specification includes gain and offset errors over temperature, and drift after 1000 hours, $T_A = 125^{\circ}C$
	-0.1	±0.02	+0.1	% FSR	$T_A = 25^{\circ}C$
Relative Accuracy (INL)	-0.02	±0.01	+0.02	% FSR	4 mA to 20 mA, 0 mA to 20 mA, 0 mA to 24 mA ranges
	-0.03	±0.015	+0.03	% FSR	±20 mA, ±24 mA ranges
Offset Error	-14		+14	μΑ	4 mA to 20 mA, 0 mA to 20 mA, 0 mA to 24 mA ranges
	-11	+5	+11	μA	$T_A = 25^{\circ}C$
	-20		+20	μA	±20 mA, ±24 mA ranges
	-15	+8	+15	μA	$T_A = 25^{\circ}C$
Offset Error TC <sup>2</sup>		±2		ppm FSR/°C	All ranges
Bipolar Zero Error	-32		+32	μA	All ranges
	-22	+12	+22	μA	$T_A = 25^{\circ}C$
Bipolar Zero TC <sup>2</sup>		±0.5		ppm FSR/°C	
Gain Error	-0.08		+0.08	% FSR	All ranges
	-0.07	±0.02	+0.07	% FSR	$T_A = 25^{\circ}C$
Gain TC		±1		ppm FSR/°C	All ranges
Full-Scale Error	-0.1		+0.1	% FSR	All ranges
	-0.07	±0.02	+0.07	% FSR	$T_A = 25^{\circ}C$
Full-Scale TC <sup>2</sup>	0.07	±0.02 ±2	10.07	ppm FSR/°C	All ranges
URRENT OUTPUT CHARACTERISTICS <sup>2</sup>				ppinion, c	, and iges
Current Loop Compliance Voltage	0		AV <sub>DD</sub> – 2.75	v	
Resistive Load		See comments		, ,	Chosen such that compliance is not exceeded
Inductive Load		See comments			Needs appropriate capacitor at higher inductance values; see the Driving Inductive Loads section
Settling Time					
4 mA to 20 mA, Full-Scale Step		8.5		μs	250 Ω load
120 μA Step, 4 mA to 20 mA Range		1.2		μs	250 Ω load
DC PSRR			1	μA/V	
Output Impedance		130		MΩ	
DIGITAL INPUT					JEDEC compliant
Input High Voltage, V <sub>H</sub>	2			V	
Input Low Voltage, V <sub>L</sub>			0.8	V	
Input Current	-1		+1	μA	Per pin
Pin Capacitance		5		pF	Per pin

Parameter <sup>1</sup>	Min	Тур	Max	Unit	Test Conditions/Comments
DIGITAL OUTPUTS <sup>2</sup>					
FAULT, IFAULT, TEMP, VFAULT					
Output Low Voltage, Vol			0.4	V	10 kΩ pull-up resistor to DVCC
Output Low Voltage, Vol		0.6		V	@ 2.5 mA
Output High Voltage, Vон	3.6			V	10 kΩ pull-up resistor to DVCC
SDO					
Output Low Voltage, Vol	0.5	0.5		V	Sinking 200 μA
Output High Voltage, Vон	DVCC – 0.5	DVCC – 0.5		V	Sourcing 200 μA
High Impedance Output Capacitance		3		pF	
High Impedance Leakage Current	-1		+1	μΑ	
POWER REQUIREMENTS					
AVDD	12		24	v	±10%
AVss	-12		-24	v	±10%
DVcc	12		2.		
Input Voltage	2.7		5.5	v	
Alp		4.4	5.2	mA	Output unloaded, output disabled
		5.2	6.2	mA	Current output enabled
		5.2	6.2	mA	Voltage output enabled
Al <sub>ss</sub>		2.0	2.5	mA	Output unloaded, output disabled
		2.5	3	mA	Current output enabled
		2.5	3	mA	Voltage output enabled
DI <sub>cc</sub>		0.3	1	mA	$V_{IH} = DVCC, V_{IL} = GND$
Power Dissipation		108		mW	AVDD/AVSS = $\pm 24$ V, outputs unloaded

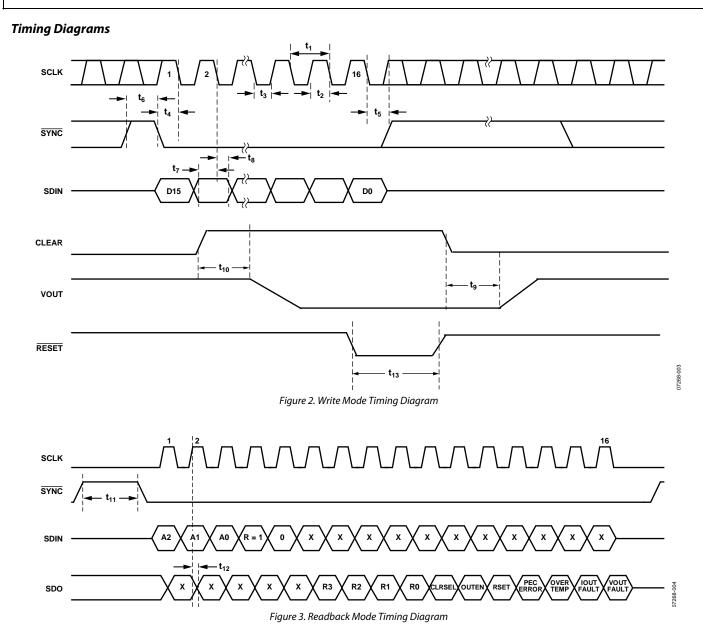
 $^1$  Temperature range: –40°C to +105°C; typical at +25°C.  $^2$  Guaranteed by characterization, but not production tested.

#### **TIMING CHARACTERISTICS**

AVDD/AVSS =  $\pm 12$  V ( $\pm 10\%$ ) to  $\pm 24$  V ( $\pm 10\%$ ), DVCC = 2.7 V to 5.5 V, GND = 0 V. VOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k $\Omega$ , C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 200 pF, IOUT: R<sub>LOAD</sub> = 2 k \Omega, C<sub>L</sub> = 2 k R<sub>LOAD</sub> = 2 k R<sub></sub> 300  $\Omega.$  All specifications  $T_{\text{MIN}}$  to  $T_{\text{MAX}}$  , unless otherwise noted.

Table 3.			
Parameter <sup>1, 2</sup>	Limit at T <sub>MIN</sub> , T <sub>MAX</sub>	Unit	Description
t <sub>1</sub>	20	ns min	SCLK cycle time
t <sub>2</sub>	8	ns min	SCLK high time
t <sub>3</sub>	8	ns min	SCLK low time
<b>t</b> <sub>4</sub>	5	ns min	SYNC falling edge to SCLK falling edge setup time
t5	10	ns min	16 <sup>th</sup> SCLK falling edge to SYNC rising edge (on 24 <sup>th</sup> SCLK falling edge if using PEC)
t <sub>6</sub>	5	ns min	Minimum SYNC high time (write mode)
t <sub>7</sub>	5	ns min	Data setup time
t <sub>8</sub>	5	ns min	Data hold time
t9, t10	1.5	µs max	CLEAR pulse low/high activation time
t11	5	ns min	Minimum SYNC high time (read mode)
t <sub>12</sub>	40	ns max	SCLK rising edge to SDO valid (SDO $C_L = 15 \text{ pF}$ )
t <sub>13</sub>	10	ns min	RESET pulse low time

 $^1$  Guaranteed by characterization, but not production tested.  $^2$  All input signals are specified with  $t_R$  =  $t_F$  = 5 ns (10% to 90% of DV<sub>CC</sub>) and timed from a voltage level of 1.2 V.



### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25^{\circ}C$  unless otherwise noted.

Transient currents of up to 100 mA do not cause SCR latch-up.

#### Table 4.

Parameter	Rating
AVDD to GND	-0.3 V to +30 V
AVSS to GND	+0.3 V to -28 V
AVDD to AVSS	–0.3 V to +58 V
DVCC to GND	–0.3 V to +7 V
VSENSE+ to GND	AV <sub>ss</sub> to AV <sub>DD</sub>
VSENSE- to GND	±5.0 V
Digital Inputs to GND	-0.3 V to DV <sub>cc</sub> + 0.3 V or 7 V (whichever is less)
Digital Outputs to GND	-0.3 V to DV <sub>cc</sub> + 0.3 V or 7 V (whichever is less)
VREF to GND	–0.3 V to +7 V
VIN to GND	–0.3 V to +7 V
VOUT, IOUT to GND	AV <sub>ss</sub> to AV <sub>DD</sub>
Operating Temperature Range, Industrial	−40°C to +105°C
Storage Temperature Range	–65°C to +150°C
Junction Temperature (TJ max)	125°C
32-Lead LFCSP Package	
$\theta_{JA}$ Thermal Impedance	28°C/W
Lead Temperature	JEDEC industry standard
Soldering	J-STD-020
ESD (Human Body Model)	3 kV

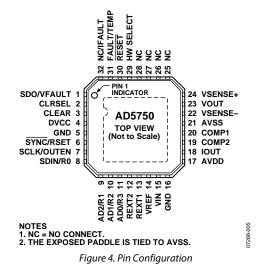
Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

### **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**

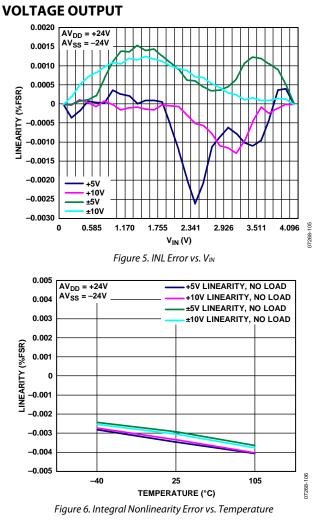


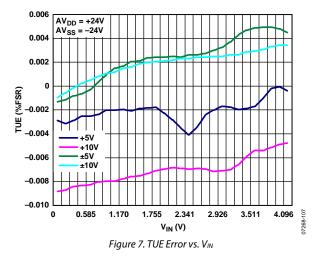
#### **Table 4. Pin Function Descriptions**

Pin No.	Mnemonic	Description
1	SDO/VFAULT	Serial Data Output (SDO). In software mode, this pin is used to clock data from the input shift register in readback mode. Data is clocked out on the rising edge of SCLK and is valid on the falling edge of SCLK. This pin is a CMOS output.
		Short-Circuit Fault Alert (VFAULT). In hardware mode, this pin acts as a short-circuit fault alert pin and is asserted low when a short-circuit error is detected. This pin is an open-drain output and must be connected to a pull-up resistor.
2	CLRSEL	In hardware or software mode, this pin selects the clear value, either zero-scale or midscale code. In software mode, this pin is implemented as a logic OR with the internal CLRSEL bit.
3	CLEAR	Active High Input. Asserting this pin sets the output current/voltage to zero-scale code or midscale code of the range selected (user-selectable). CLEAR is a logic OR with the internal clear bit.
		In software mode, during power-up, the CLEAR pin level determines the power-on condition of the voltage channel, which can be active 0 V or tristate. See the Asynchronous Clear (CLEAR) section for more details.
4	DVCC	Digital Power Supply.
5	GND	Ground Connection.
6	SYNC/RSET	Positive Edge-Sensitive Latch (SYNC). In software mode, a rising edge parallel loads the input shift register dat into the AD5750, also updating the output.
		Resistor Select (RSET). In hardware mode, this pin chooses whether the internal or the external current sense resistor is used.
		If RSET = 0, the external sense resistor is chosen.
		If RSET = 1, the internal sense Resistor is chosen.
7	SCLK/OUTEN	Serial Clock Input (SCLK). In software mode, data is clocked into the input shift register on the falling edge of SCLK. This pin operates at clock speeds up to 50 MHz.
		Output Enable (OUTEN). In hardware mode, this pin acts as an output enable pin.
8	SDIN/R0	Serial Data Input (SDIN). In software mode, data must be valid on the falling edge of SCLK.
		Range Decode Bit (R0). In hardware mode, this pin, in conjunction with R1, R2, and R3, chooses the output current/voltage range setting on the part.
9	AD2/R1	Device Addressing Bit (AD2). In software mode, this pin, in conjunction with AD1 and AD0, allows up to eight devices to be addressed on one bus.
		Range Decode Bit (R1). In hardware mode, this pin, in conjunction with R0, R2, and R3, chooses the output current/voltage range setting on the part.
10	AD1/R2	Device Addressing Bit (AD1). In software mode, this pin, in conjunction with AD2 and AD0 allows up to eight devices to be addressed on one bus.
		Range Decode Bit (R2). In hardware mode, this pin, in conjunction with R0, R1, and R3, chooses the output current/voltage range setting on the part.

Pin No.	Mnemonic	Description
11	AD0/R3	Device Addressing Bit (AD0). In software mode, this pin, in conjunction with AD1 and AD2, allows up to eight devices to be addressed on one bus.
		Range Decode Bit (R3). In hardware mode, this pin, in conjunction with, R0, R1, and R2, chooses the output current/voltage range setting on the part.
12, 13	REXT1, REXT2	A 15 k $\Omega$ external current setting resistor can be connected between the REXT1 and REXT2 pins to improve the IOUT temperature drift performance.
14	VREF	Buffered Reference Input.
15	VIN	Buffered Analog Input (0 V to 4.096 V).
16	GND	Ground Connection.
17	AVDD	Positive Analog Supply Pin.
18	IOUT	Current Output Pin.
19, 20	COMP1, COMP2	Optional Compensation Capacitor Connections for the Voltage Output Buffer. These are used to drive higher capacitive loads on the output. These pins also reduce overshoot on the output. Care should be taken when choosing the value of the capacitor connected between the COMP1 and COMP2 pins because it has a direct influence on the settling time of the output. See the Driving Large Capacitive Loads section for further details.
21	AVSS	Negative Analog Supply Pin.
22	VSENSE-	Sense Connection for the Negative Voltage Output Load Connection. This pin must stay within $\pm 3.0$ V of ground for correct operation.
23	VOUT	Buffered Analog Output Voltage.
24	VSENSE+	Sense Connection for the Positive Voltage Output Load Connection.
25, 26, 27, 28	NC	No Connect Pin. Can be tied to GND.
29	HW SELECT	This pin is used to configure the part to hardware or software mode.
		HW SELECT = 0 selects software control.
		HW SELECT = 1 selects hardware control.
30	RESET	Resets the part to its power-on state.
31	FAULT/TEMP	Fault Alert (FAULT). In software mode, this pin acts as a general fault alert pin. It is asserted low when an open- circuit, short-circuit, overtemperature error, or PEC interface error is detected. This pin is an open-drain output and must be connected to a pull-up resistor.
		Overtemperature Fault (TEMP). In hardware mode, this pin acts as an overtemperature fault pin. It is asserted low when an overtemperature error is detected. This pin is an open-drain output and must be connected to a pull-up resistor.
32	NC/IFAULT	No Connect (NC). In software mode, this pin is a no connect. Instead, tie this pin to GND.
		Open-Circuit Fault Alert (IFAULT). In hardware mode, this pin acts as an open-circuit fault alert pin. It is asserted low when an open-circuit error is detected. This pin is an open-drain output and must be connected to a pull- up resistor.
33 (EPAD)	Exposed paddle	The exposed paddle is tied to AVSS.

### **TYPICAL PERFORMANCE CHARACTERISTICS**





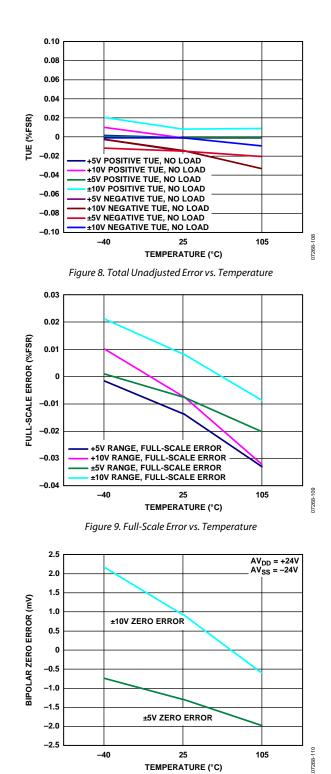
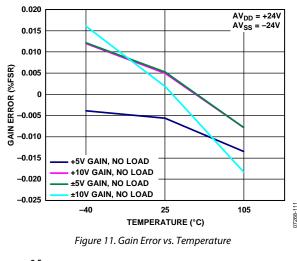


Figure 10. Bipolar Zero Error vs. Temperature



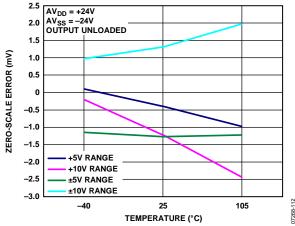
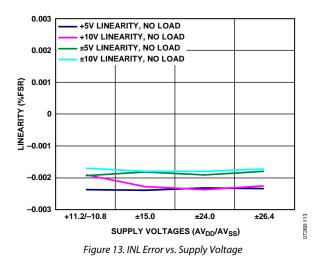
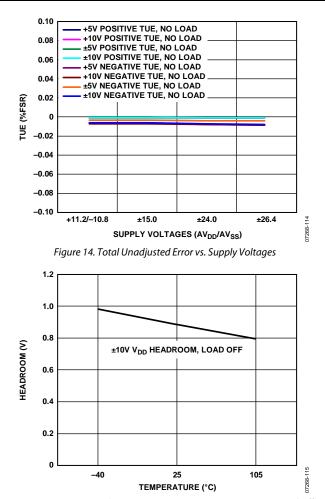
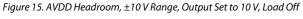
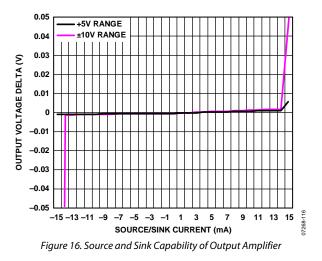


Figure 12. Zero-Scale Error (Offset Error) vs. Temperature









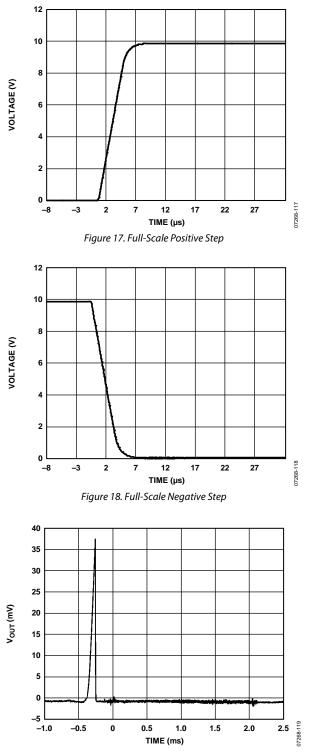


Figure 19.  $V_{OUT}$  vs. Time on Power-Up, Load =  $2 k\Omega \parallel 200 pF$ 

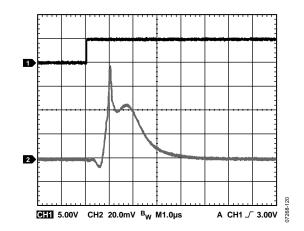


Figure 20. Vout Enable Glitch, Load =  $2 k\Omega \parallel 1 nF$ 

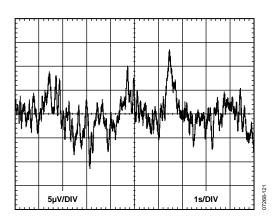
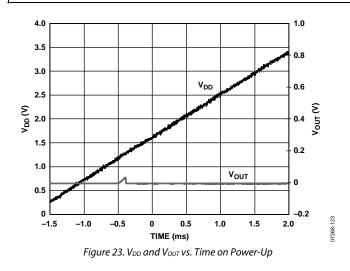


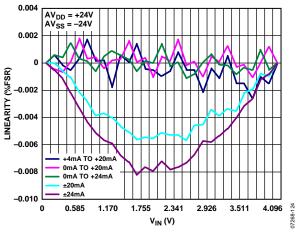
Figure 21. Peak-to-Peak Noise (0.1 Hz to 10 Hz Bandwidth)

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Figure 22. Peak-to-Peak Noise (100 kHz Bandwidth)





**CURRENT OUTPUT** 

#### Figure 24. INL Error vs. VIN, External RSET Resistor

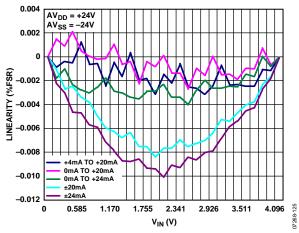


Figure 25. INL Error vs. VIN, Internal RSET Resistor

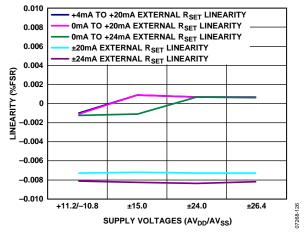


Figure 26. Integral Nonlinearity Current Mode, External R<sub>SET</sub> Sense Resistor

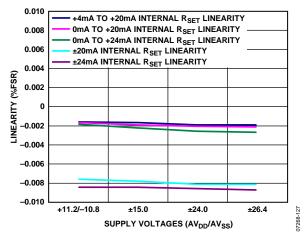
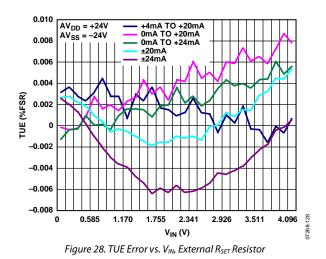
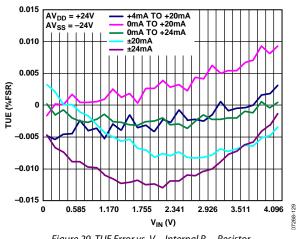


Figure 27. Integral Nonlinearity Current Mode, Internal RSET Sense Resistor





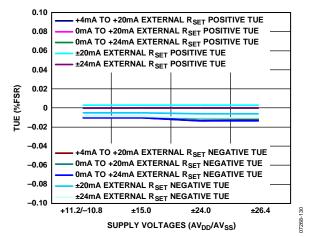


Figure 30. Total Unadjusted Error Current Mode, External R<sub>SET</sub> Sense Resistor

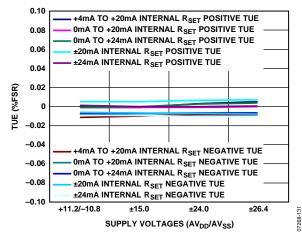
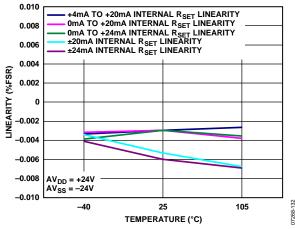


Figure 31. Total Unadjusted Error Current Mode, Internal RSET Sense Resistor





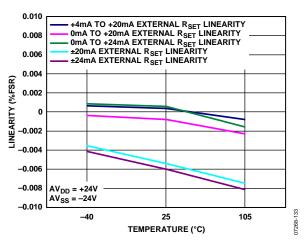


Figure 33. INL vs. Temperature, External R<sub>SET</sub> Sense Resistor

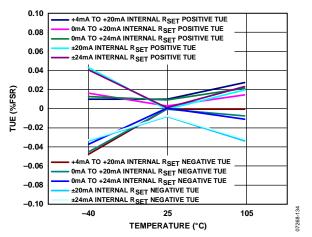


Figure 34. Total Unadjusted Error vs. Temperature, Internal R<sub>SET</sub> Sense Resistor

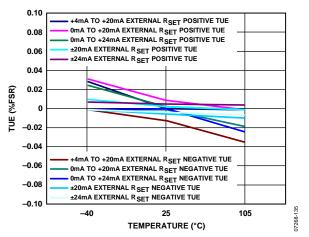


Figure 35. Total Unadjusted Error vs. Temperature, External R<sub>SET</sub> Sense Resistor

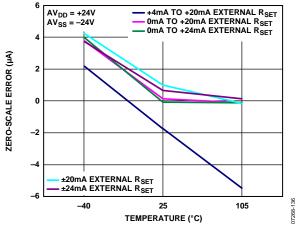


Figure 36. Zero-Scale Error vs. Temperature, External RSET Sense Resistor

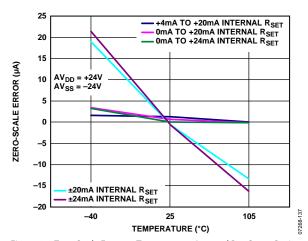


Figure 37. Zero-Scale Error vs. Temperature, Internal R<sub>SET</sub> Sense Resistor

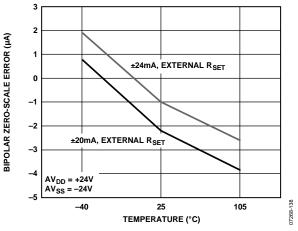
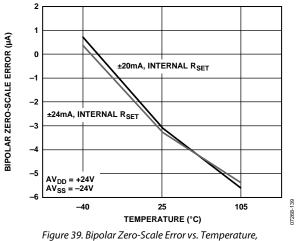


Figure 38. Bipolar Zero-Scale Error vs. Temperature, External R<sub>SET</sub> Sense Resistor



, Internal R<sub>SET</sub> Sense Resistor

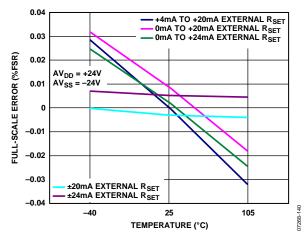


Figure 40. Full-Scale Error vs. Temperature, External R<sub>SET</sub> Sense Resistor

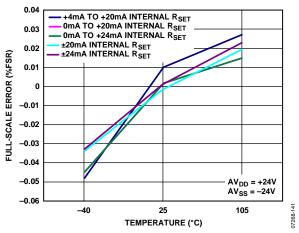


Figure 41. Full-Scale Error vs. Temperature, Internal R<sub>SET</sub> Sense Resistor

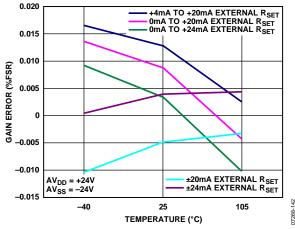


Figure 42. Gain Error vs. Temperature, External R<sub>SET</sub> Sense Resistor

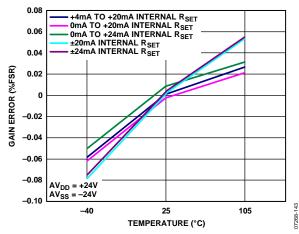


Figure 43. Gain Error vs. Temperature, Internal R<sub>SET</sub> Sense Resistor

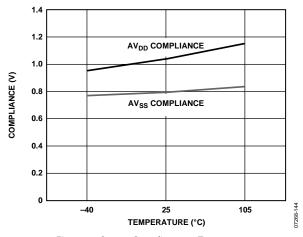
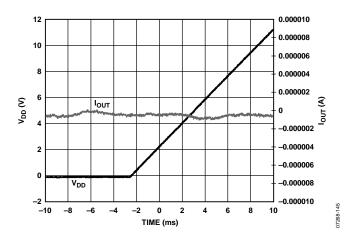
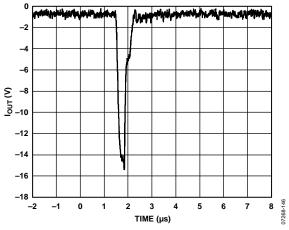
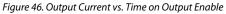


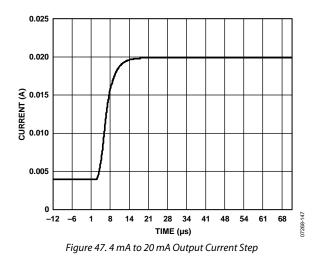
Figure 44. Output Compliance vs. Temperature Tested When  $I_{OUT} = 10.8$  mA, ±24 mA Range Selected











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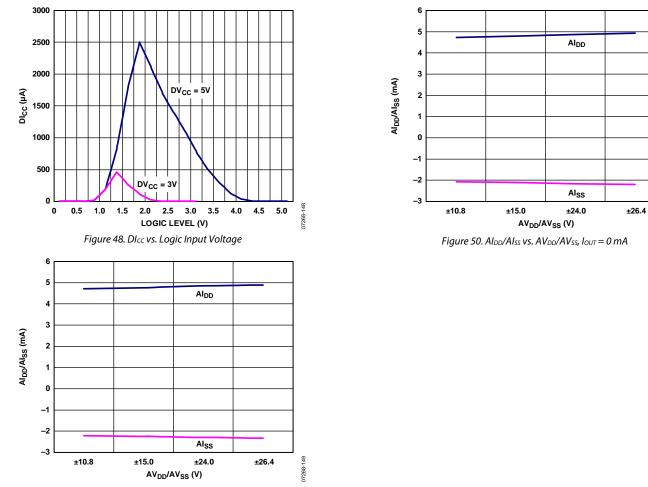


Figure 49.  $AI_{DD}/AI_{SS}$  vs.  $AV_{DD}/AV_{SS}$ ,  $V_{OUT} = 0$  V

### **TERMINOLOGY**

#### Total Unadjusted Error (TUE)

TUE is a measure of the output error taking all the various errors into account: INL error, offset error, gain error, and output drift over supplies, temperature, and time. TUE is expressed as a percentage of full-scale range (% FSR).

#### Relative Accuracy or Integral Nonlinearity (INL)

INL is a measure of the maximum deviation, in % FSR, from a straight line passing through the endpoints of the output driver transfer function. A typical INL vs. input voltage plot can be seen in Figure 5.

#### **Bipolar Zero Error**

Bipolar zero error is the deviation of the actual vs. ideal halfscale output of 0 V/0 mA with a bipolar range selected. A plot of bipolar zero error vs. temperature can be seen in Figure 10.

#### **Bipolar Zero TC**

Bipolar zero TC is a measure of the change in the bipolar zero error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Full-Scale Error**

Full-scale error is the deviation of the actual full-scale analog output from the ideal full-scale output. Full-scale error is expressed as a percentage of full-scale range (% FSR).

#### Full-Scale TC

Full-scale TC is a measure of the change in the full-scale error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Gain Error**

Gain error is a measure of the span error of the output. It is the deviation in slope of the output transfer characteristic from the ideal expressed in % FSR. A plot of gain error vs. temperature can be seen in Figure 11.

#### **Gain Error TC**

Gain error TC is a measure of the change in gain error with changes in temperature. Gain error TC is expressed in ppm FSR/°C.

#### Zero-Scale Error

Zero-scale error is the deviation of the actual zero-scale analog output from the ideal zero-scale output. Zero-scale error is expressed in millivolts (mV).

#### Zero-Scale TC

Zero-scale TC is a measure of the change in zero-scale error with a change in temperature. Zero-scale error TC is expressed in ppm FSR/°C.

#### **Offset Error**

Offset error is a measurement of the difference between VOUT (actual) and VOUT (ideal) expressed in millivolts (mV) in the linear region of the transfer function. It can be negative or positive.

#### **Output Voltage Settling Time**

Output voltage settling time is the amount of time it takes for the output to settle to a specified level for a half-scale input change.

#### Slew Rate

The slew rate of a device is a limitation in the rate of change of the output voltage. The output slewing speed is usually limited by the slew rate of the amplifier used at its output. Slew rate is measured from 10% to 90% of the output signal and is expressed in  $V/\mu s$ .

#### **Current Loop Voltage Compliance**

Current loop voltage compliance is the maximum voltage at the IOUT pin for which the output current is equal to the programmed value.

#### **Power-On Glitch Energy**

Power-on glitch energy is the impulse injected into the analog output when the AD5750 is powered on. It is specified as the area of the glitch in nV-sec.

#### Power Supply Rejection Ratio (PSRR)

PSRR indicates how the output is affected by changes in the power supply voltage.

### THEORY OF OPERATION

The AD5750 is a single-channel, precision, voltage/current output driver with hardware or software programmable output ranges. The software ranges are configured via an SPI-/ MICROWIRE-compatible serial interface. The analog input to the AD5750 is provided from a low voltage, single-supply, digital-to-analog converter and is internally conditioned to provide the desired output current/voltage range. The analog input range is 0 V to 4.096 V.

The output current range is programmable across five current ranges: 4 mA to 20 mA, 0 mA to 20 mA or 0 mA to 24 mA,  $\pm 20$  mA, and  $\pm 24$  mA.

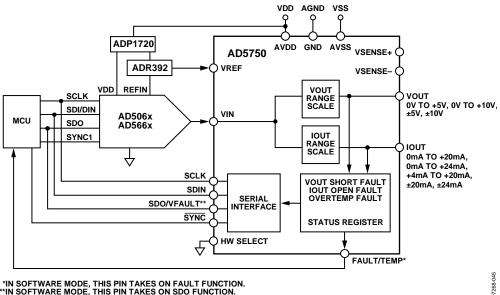
The voltage output is provided from a separate pin that can be configured to provide 0 V to 5 V, 0 V to 10 V, ±5 V, or ±10 V output ranges. An overrange of 20% is available on the voltage ranges. An overrange of 2% is available on the 4 mA to 20 mA, 0 mA to 20 mA, and 0 mA to 24 mA current ranges. The current and voltage outputs are available on separate pins. Only one output can be enabled at one time. The output range is selected by programming the R3 to R0 bits in the control register (see Table 6 and Table 7).

Figure 51 and Figure 52 show a typical configuration of the AD5750 in software mode and in hardware mode, respectively, in an output module system. The HW SELECT pin chooses whether the part is configured in software or hardware mode. The analog input to the AD5750 is provided from a low voltage, single-supply, digital-to-analog converter (DAC) such as the AD5060 or AD5660, which provides an output range of 0 V to 4.096 V. The supply and reference for the DAC, as well as the reference for the AD5750, can be supplied from a reference such as the ADR392. The AD5750 can operate from supplies up to ±26.4 V.

#### SOFTWARE MODE

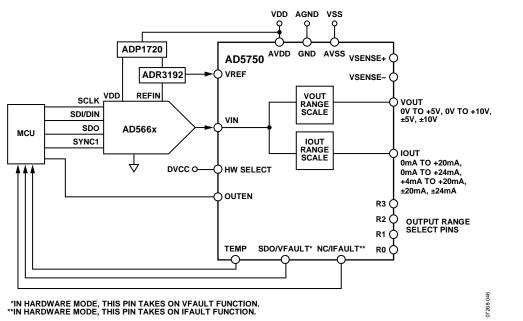
In current mode, software-selectable output ranges include ±20 mA, ±24 mA, 0 mA to 20 mA, 4 mA to 20 mA, or 0 mA to 24 mA.

In voltage mode, software-selectable output ranges include 0 V to 5 V, 0 V to 10 V,  $\pm$ 5 V, or  $\pm$ 10 V.



#### \*IN SOFTWARE MODE, THIS PIN TAKES ON FAULT FUNCTION. \*\*IN SOFTWARE MODE, THIS PIN TAKES ON SDO FUNCTION.

Figure 51. Typical System Configuration in Software Mode (Pull-Up Resistors Not Shown for Open-Drain Outputs)



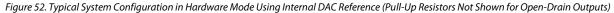


Table 5. Suggested Parts for Use with AD5750

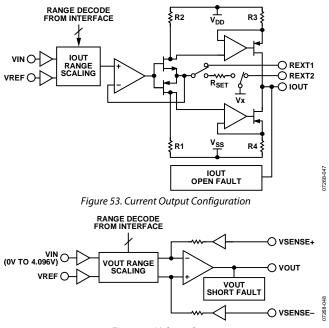
DAC Reference		Power	Accuracy	Description				
AD5660	Internal	ADP1720 <sup>1</sup>	12-bit INL	Mid end system, single channel, internal reference				
AD5664R	Internal	N/A	N/A Mid end system, quad channel, internal reference					
AD5668	Internal	N/A	N/A Mid end system, octal channel, internal reference					
AD5060	ADR434	ADP1720	16-bit INL	High end system, single channel, external reference				
AD5064	ADR434	N/A	N/A	High end system, quad channel, external reference				
AD5662	ADR392 <sup>2</sup>	ADR392 <sup>2</sup>	12-bit INL	Mid end system, single channel, external reference				
AD5664	ADR392 <sup>2</sup>	N/A	N/A Mid end system, quad channel, external reference					

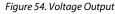
<sup>1</sup> ADP1720 input range up to 28 V.

<sup>2</sup> ADR392 input range up to 15 V.

#### **CURRENT OUTPUT ARCHITECTURE**

The voltage input from the analog input VIN pin (0 V to 4.096 V) is either converted to a current (see Figure 53), which is then mirrored to the supply rail so that the application simply sees a current source output with respect to an internal reference voltage, or it is buffered and scaled to output a software-selectable unipolar or bipolar voltage range (see Figure 54). The reference is used to provide internal offsets for range and gain scaling. The selectable output range is programmable through the digital interface.





#### **DRIVING INDUCTIVE LOADS**

When driving inductive or poorly defined loads, connect a 0.01  $\mu$ F capacitor between IOUT and GND. This ensures stability with loads beyond 50 mH. There is no maximum capacitance limit. The capacitive component of the load may cause slower settling.

#### Voltage Output Amplifier

The voltage output amplifier is capable of generating both unipolar and bipolar output voltages. It is capable of driving a load of 1 k $\Omega$  in parallel with 1.2  $\mu F$  (with an external compensation capacitor on the COMP1 and COMP2 pins). The source and sink capabilities of the output amplifier can be seen in Figure 16. The slew rate is 2 V/ $\mu s.$ 

Internal to the device, there is a 2.5 M $\Omega$  resistor connected between the VOUT and VSENSE+ pins and similarly between the VSENSE– pin and the internal device ground. Should a fault condition occur, these resistors act to protect the AD5750 by ensuring the amplifier loop is closed so that the part does not enter into an open-loop condition.

The VSENSE– pin can work in a common-mode range of  $\pm 3$  V with respect to the remote load ground point.

The current and voltage are output on separate pins and cannot be output simultaneously. This allows the user to tie both the current and voltage output pins together and configure the end system as a single-channel output.

#### **Driving Large Capacitive Loads**

The voltage output amplifier is capable of driving capacitive loads of up to 1  $\mu F$  with the addition of a nonpolarized compensation capacitor between the COMP1 and COMP2 pins.

Without the compensation capacitor, up to 20 nF capacitive loads can be driven. Care should be taken to choose an appropriate value for the  $C_{COMP}$  capacitor. This capacitor, while allowing the AD5750 to drive higher capacitive loads and reduce overshoot, increases the settling time of the part and therefore affects the bandwidth of the system. Considered values of this capacitor should be in the range 100 pF to 4 nF depending on the trade-off required between settling time, overshoot, and bandwidth.

#### **POWER-ON STATE OF AD5750**

On power-up, the AD5750 senses whether hardware or software mode is loaded and sets the power-up conditions accordingly.

In software SPI mode, the power-up state of the output is dependent on the state of the CLEAR pin. If the CLEAR pin is pulled high, then the part powers up, driving an active 0 V on the output. If the CLEAR pin is pulled low, then the part powers up with the voltage output channel in tristate mode. In both cases, the current output channel powers up in tristate condition (0 mA). This allows the voltage and current outputs to be connected together if desired.

To put the part into normal operation, the user must set the OUTEN bit in the control register to enable the output and, in the same write, set the output range configuration using the R3 to R0 range bits. If the CLEAR pin is still high (active) during this write, the part automatically clears to its normal clear state as defined by the programmed range and by the CLR SELECT pin or CLRSEL bit (see the Asynchronous Clear (CLEAR) section for more details). The CLEAR pin must be taken low to operate the part in normal mode.

The CLEAR pin is typically driven directly from a microcontroller. In cases where the power supply for the AD5750 supply may be independent of the microcontroller power supply, the user can connect a weak pull-up resistor to DVCC or a pull-down resistor to ground to ensure that the correct power-up condition is achieved independent of the microcontroller. A 10 k $\Omega$  pull-up/ pull-down resistor on the CLEAR pin should be sufficient for most applications.

If hardware mode is selected, the part powers up to the conditions defined by the R3 to R0 range bits and the status of the OUTEN or CLEAR pin. It is recommended to keep the output disabled when powering up the part in hardware mode.

#### **DEFAULT REGISTERS AT POWER-ON**

The AD5750 power-on-reset circuit ensures that all registers are loaded with zero code.

In software SPI mode, the part powers up with all outputs disabled (OUTEN bit = 0). The user must set the OUTEN bit in the control register to enable the output and, in the same write, set the output range configuration using the R3 to R0 bits.

If hardware mode is selected, the part powers up to the conditions defined by the R3 to R0 bits and the status of the OUTEN pin. It is recommended to keep the output disabled when powering up the part in hardware mode.

#### **RESET FUNCTION**

In software mode, the part can be reset using the  $\overline{\text{RESET}}$  pin (active low) or the reset bit (reset = 1). A reset disables both the current and voltage outputs to their power-on condition. The user must write to the OUTEN bit to enable the output and, in the same write, set the output range configuration. The  $\overline{\text{RESET}}$  pin is a level-sensitive input; the part stays in reset mode as long as the  $\overline{\text{RESET}}$  pin is low. The reset bit clears to 0 following a reset command to the control register.

In hardware mode, there is no reset. If using the part in hardware mode, the  $\overrightarrow{\text{RESET}}$  pin should be tied high.

#### OUTEN

MCR

In software mode, the output can be enabled or disabled using the OUTEN bit in the control register. When the output is disabled, both the current and voltage channels both go into tristate. The user must set the OUTEN bit to enable the output and simultaneously set the output range configuration.

In hardware mode, the output can be enabled or disabled using the OUTEN pin. When the output is disabled, both the current and voltage channels both go into tristate. The user must write to the OUTEN pin to enable the output. It is recommended that the output be disabled when changing the ranges.

#### SOFTWARE CONTROL

Software control is enabled by connecting the HW SELECT pin to ground. In software mode, the AD5750 is controlled over a versatile 3-wire serial interface that operates at clock rates up to 50 MHz. It is compatible with SPI, QSPI<sup>™</sup>, MICROWIRE, and DSP standards.

#### Input Shift Register

The input shift register is 16 bits wide. Data is loaded into the device MSB first as a 16-bit word under the control of a serial clock input, SCLK. Data is clocked in on the falling edge of SCLK. The input shift register consists of 16 control bits, as shown in Table 6. The timing diagram for this write operation is shown in Figure 2. The first three bits of the input shift register are used to set the hardware address of the AD5750 device on the printed circuit board (PCB). Up to eight devices can be addressed per board.

Bit D11, Bit D1, and Bit D0 must always be set to 0 during any write sequence.

I SR

#### Table 6. Input Shift Register Contents for a Write Operation—Control Register

11150												200			
D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
A2	A1	A0	R/W	0	R3	R2	R1	RO	CLRSEL	OUTEN	Clear	RSET	Reset	0	0

Bit	Descr	Description								
A2, A1, A0		Used in association with the AD2, AD1, and AD0 external pins to determine which part is being addressed by the system controller.								
	A2	A1	Function							
	0	0	0	Addresses part with Pin AD2 = 0, Pin AD1 = 0, Pin AD0 = 0.						
	0	0	1	Addresses part with Pin AD2 = 0, Pin AD1 = 0, Pin AD0 = 1.						
	0	1	0	Addresses part with Pin AD2 = 0, Pin AD1 = 1, Pin AD0 = 0.						
	0	1	1	Addresses part with Pin AD2 = 0, Pin AD1 = 1, Pin AD0 = 1.						
	1	0	0	Addresses part with Pin AD2 = 1, Pin AD1 = 0, Pin AD0 = 0.						
	1	0	1	Addresses part with Pin AD2 = 1, Pin AD1 = 0, Pin AD0 = 1.						
	1	1	0	Addresses part with Pin AD2 = 1, Pin AD1 = 1, Pin AD0 = 0.						
	1	1	1	Addresses part with Pin AD2 = 1, Pin AD1 = 1, Pin AD0 = 1.						
R/W	Indica	Indicates a read from or a write to the addressed register.								

#### Table 7. Input Shift Register Descriptions

Bit	Descri	Description									
3, R2, R1, R0		Selects output configuration in conjunction with RSET.									
	RSET	R3	R2	R1	RO	Output Configuration					
	0	0	0	0	0	4 mA to 20 mA (external 15 k $\Omega$ current sense resistor).					
	0	0	0	0	1	0 mA to 20 mA (external 15 k $\Omega$ current sense resistor).					
	0	0	0	1	0 0 mA to 24 mA (external 15 k $\Omega$ current sense resistor).	0 mA to 24 mA (external 15 k $\Omega$ current sense resistor).	0 0 mA to 24 mA (external 15 k $\Omega$ current sense resistor).		0 mA to 24 mA (external 15 k $\Omega$ current sense resistor).		
	0	0	0	1	1	$\pm 20$ mA (external 15 k $\Omega$ current sense resistor).					
	0	0	1	0	0	$\pm 24$ mA (external 15 k $\Omega$ current sense resistor).					
	0	0	1	0	1	0 V to 5 V.					
	0	0	1	1	0	0 V to 10 V.					
	0	0	1	1	1	±5 V.					
	0	1	0	0	0	±10 V.					
	0	1	0	0	1	0 V to 6.0 V (20% overrange).					
	0	1	0	1	0	0 V to 12.0 V (20% overrange).					
	0	1	0	1	1	±6.0 V (20% overrange).					
	0	1	1	0	0	±12.0 V (20% overrange).					
	0	1	1	0	1	±2.5 V.					
	0	1	1	1	0	N/A; if selected, output drives between 0 V and $-1$ V.					
	0 1		1	1	1	N/A; if selected, output drives between 0 V and $-1$ V.					
	1	0	0	0	0	4 mA to 20 mA (internal current sense resistor).					
	1	0	0	0	1	0 mA to 20 mA (internal current sense resistor).					
	1	0	0	1	0	0 mA to 24 mA (internal current sense resistor).					
	1	0	0	1	1	±20 mA (internal current sense resistor).					
	1	0	1	0	0	±24 mA (internal current sense resistor).					
	1	0	1	0	1	0 V to 5 V.					
	1	0	1	1	0	0 V to 10 V.					
	1	0	1	1	1	±5 V.					
	1	1	0	0	0	±10 V.					
	1	1	0	0	1	0 V to 6.0 V (20% overrange).					
	1	1	0	1	0	0 V to 12.0 V (20% overrange).					
	1	1	0	1	1	±6.0 V (20% overrange).					
	1	1	1	0	0	±12.0 V (20% overrange).					
	1	1	1	0	1	3.92 mA to 20.4 mA (internal current sense resistor).					
	1	1	1	1	0	0 mA to 20.4 mA (internal current sense resistor).					
	1	1	1	1	1	0 mA to 24.5 mA (internal current sense resistor).					
RSEL	Sets cl	ear mo	de to zero	scale or	midscale	e. See the Asynchronous Clear (CLEAR) section.					
	CLRSE		Functio	·							
	0		Clear to								
	1				in unipo	lar mode; clear to zero scale in bipolar mode.					
JTEN	Outpu	t enab				o 1 to enable the outputs.					
ear			ar bit, activ								
ET			al/external	-	sense res	sistor.					
	RSET		Functio								
	1				irrent sen	ise resistor; used with R3 to R0 bits to select range.					
						-					
set		0Select external current sense resistor; used with R3 to R0 bits to select range.Resets the part to its power-on state.									

#### **Readback Operation**

Readback mode is activated by selecting the correct device address (A2, A1, A0) and then setting the R/W bit to 1. By default, the SDO pin is disabled. After having addressed the AD5750 for a read operation, setting R/W to 1 enables the SDO pin and SDO data is clocked out on the 5<sup>th</sup> rising edge of SCLK. After the data has been clocked out on SDO, a rising edge on SYNC disables (tristate) the SDO pin again. Status register data (see Table 8) and control register data are both available during the same read cycle.

The status bits comprise four read-only bits. They are used to notify the user of specific fault conditions that occur, such as an open circuit or short circuit on the output, overtemperature error, or an interface error. If any of these fault conditions occur, a hardware FAULT is also asserted low, which can be used as a hardware interrupt to the controller.

See the Detailed Description of Features section for a full explanation of fault conditions.

#### HARDWARE CONTROL

Hardware control is enabled by connecting the HW SELECT pin to DVCC. In this mode, the R3, R2, R1, and R0 pins in conjunction with the RSET pin are used to configure the output range, as per Table 7. In hardware mode, there is no status register. The fault conditions (open circuit, short circuit, and overtemperature) are available on Pin IFAULT, Pin VFAULT, and Pin TEMP. If any one of these fault conditions are set, then a low is asserted on the specific fault pin. IFAULT, VFAULT, and TEMP are opendrain outputs and therefore can be connected together to allow the user to generate one interrupt to the system controller to communicate a fault. If hardwired in this way, it is not possible to isolate which fault occurred in the system.

#### TRANSFER FUNCTION

The AD5750 consists of an internal signal conditioning block that maps the analog input voltage to a programmed output range. The available analog input range is 0 V to 4.096 V.

For all ranges, both current and voltage, the AD5750 implements a straight linear mapping function. 0 V maps to the lower end of the selected range; 4.096 V maps to the upper end of the selected range.

#### Table 8. Input Shift Register Contents for a Read Operation—Status Register

MSB															LSB
D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
A2	A1	A0	1	0	R3	R2	R1	RO	CLRSEL	OUTEN	RSET	PEC error	OVER TEMP	IOUT fault	VOUT fault

#### Table 9. Status Bit Options

Bit	Description
PEC Error	This bit is set if there is an interface error detected by CRC-8 error checking. See the Detailed Description of Features section.
VOUT Fault	This bit is set if there is a short circuit on the VOUT pin.
IOUT Fault	This bit is set is there is an open circuit on the IOUT pin.
OVER TEMP	This bit is set if the AD5750 core temperature exceeds approximately 150°C.

### **DETAILED DESCRIPTION OF FEATURES** OUTPUT FAULT ALERT—SOFTWARE MODE

In software mode, the AD5750 is equipped with one FAULT pin; this is an open-drain output allowing several AD5750 devices to be connected together to one pull-up resistor for global fault detection. In software mode, the FAULT pin is forced active low by any one of the following fault scenarios:

- The voltage at IOUT attempts to rise above the compliance range, due to an open-loop circuit or insufficient power supply voltage. The internal circuitry that develops the fault output avoids using a comparator with window limits because this requires an actual output error before the fault output becomes active. Instead, the signal is generated when the internal amplifier in the output stage has less than approximately 1 V of remaining drive capability. Thus, the fault output activates slightly before the compliance limit is reached. Because the comparison is made within the feedback loop of the output amplifier, the output accuracy is maintained by its open-loop gain, and an output error does not occur before the fault output becomes active.
- A short is detected on the voltage output pin (VOUT). The short-circuit current is limited to 15 mA.
- An interface error is detected due to packet error checking (PEC) failure. See the Packet Error Checking section.
- If the core temperature of the AD5750 exceeds approximately 150°C.

#### OUTPUT FAULT ALERT—HARDWARE MODE

In hardware mode, the AD5750 is equipped with three fault pins: VFAULT, IFAULT, and TEMP. These are open-drain outputs allowing several AD5750 devices to be connected together to one pull-up resistor for global fault detection. In hardware control mode, these fault pins are forced active by any one of the following fault scenarios:

• Open-circuit detect. The voltage at IOUT attempts to rise above the compliance range, due to an open-loop circuit or insufficient power supply voltage. The internal circuitry

that develops the fault output avoids using a comparator with window limits because this requires an actual output error before the fault output becomes active. Instead, the signal is generated when the internal amplifier in the output stage has less than approximately 1 V of remaining drive capability. Thus, the fault output activates slightly before the compliance limit is reached. Because the comparison is made within the feedback loop of the output amplifier, the output accuracy is maintained by its open-loop gain, and an output error does not occur before the fault output becomes active. If this fault is detected, the IFAULT pin is forced low.

- A short is detected on the voltage output pin (VOUT). The short-circuit current is limited to 15 mA. If this fault is detected, the VFAULT pin is forced low.
- If the core temperature of the AD5750 exceeds approximately 150°C. If this fault is detected, the TEMP pin is forced low.

#### **VOLTAGE OUTPUT SHORT-CIRCUIT PROTECTION**

Under normal operation, the voltage output sinks and sources up to 12 mA and maintains specified operation. The maximum current that the voltage output delivers is 15 mA; this is the short-circuit current.

#### **ASYNCHRONOUS CLEAR (CLEAR)**

CLEAR is an active high clear that allows the voltage output to be cleared to either zero-scale code or midscale code, userselectable via the CLRSEL pin or the CLRSEL bit of the input shift register, as described in Table 7. (The clear select feature is a logical OR function of the CLRSEL pin and the CLRSEL bit). The current loop output clears to the bottom of its programmed range. When the CLEAR signal is returned low, the output returns to its programmed value or a new value if programmed. A clear operation can also be performed via the clear command in the control register.

		Output Clear Value									
CLRSEL	Unipolar Output Voltage Range	Unipolar Current Output Range	Bipolar Output Range	Bipolar Current Output Range							
0	0 V	Zero scale; for example: 4 mA on the 4 mA to 20 mA range 0 mA on the 0 mA to 20 mA range	Negative full scale	Zero scale; for example, -24 mA on the $\pm$ 24 mA range							
1	Midscale	Midscale; for example: 12 mA on the 4 mA to 20 mA range 10 mA on the 0 mA to 20 mA range	0 V	Midscale; for example, 0 mA on the ±24 mA range							

#### Table 10. CLRSEL Options

#### **EXTERNAL CURRENT SETTING RESISTOR**

Referring to Figure 1,  $R_{SET}$  is an internal sense resistor as part of the voltage-to-current conversion circuitry. The nominal value of internal current sense resistor is 15 k $\Omega$ . To allow for overrange capability in current mode, the user can also select the internal current sense resistor to be 14.7 k $\Omega$ , giving a nominal 2% overrange capability. This feature is available in the 0 mA to 20 mA, 4 mA to 20 mA, and ±20 mA current ranges.

The stability of the output current value over temperature is dependent on the stability of the value of  $R_{SET}$ . As a method of improving the stability of the output current over temperature, an external low drift resistor can be connected to the REXT1 and REXT2 pins of the AD5750, which can be used instead of the internal resistor. The external resistor is selected via the input shift register. If the external resistor option is not used, the REXT1 and REXT2 pins should be left floating.

#### **PROGRAMMABLE OVERRANGE MODES**

The AD5750 contains an overrange mode for most of the available ranges. The overranges are selected by configuring the R3, R1, R1, and R0 bits (or pins) accordingly.

In voltage mode, the overranges are typically 20% providing programmable output ranges of 0 V to 6 V, 0 V to 12 V,  $\pm$ 6 V, and  $\pm$ 12 V. The 0 V to 4.096 V analog input remains the same.

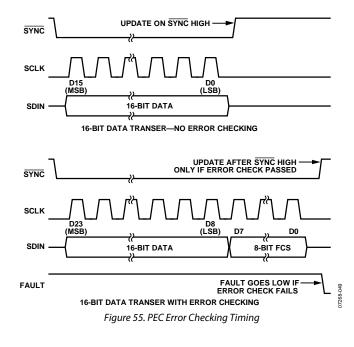
In current mode, the overranges are typically 2%. In current mode, the overrange capability is only available on three ranges, 0 mA to 20 mA, 0 mA to 24 mA, and 4 mA to 20 mA. For these ranges, the analog input also remains the same (0 V to 4.096 V).

#### **PACKET ERROR CHECKING**

To verify that data has been received correctly in noisy environments, the AD5750 offers the option of error checking based on an 8-bit (CRC-8) cyclic redundancy check. The device controlling the AD5750 should generate an 8-bit frame check sequence using the following polynomial:

 $C(x) = x_8 + x_2 + x_1 + 1$ 

This is added to the end of the data-word, and 24 data bits are sent to the AD5750 before taking  $\overline{\text{SYNC}}$  high. If the AD5750 receives a 24-bit data frame, it performs the error check when  $\overline{\text{SYNC}}$  goes high. If the check is valid, then the data is written to the selected register. If the error check fails, the FAULT pin goes low and Bit D3 of the status register is set. After reading this register, this error flag is cleared automatically and the FAULT pin goes high again.



### **APPLICATIONS INFORMATION** TRANSIENT VOLTAGE PROTECTION

The AD5750 contains ESD protection diodes that prevent damage from normal handling. The industrial control environment can, however, subject I/O circuits to much higher transients. To protect the AD5750 from excessively high voltage transients, external power diodes and a surge current limiting resistor may be required, as shown in Figure 56. The constraint on the resistor value is that during normal operation the output level at IOUT must remain within its voltage compliance limit of  $AV_{DD} - 2.75$  V and the two protection diodes and resistor must have appropriate power ratings. Further protection can be added with transient voltage suppressors if needed.

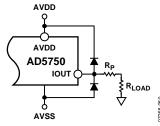


Figure 56. Output Transient Voltage Protection

#### THERMAL CONSIDERATIONS

It is important to understand the effects of power dissipation on the package and how it affects junction temperature. The internal junction temperature should not exceed 125°C. The AD5750 is packaged in a 32-lead LFCSP 5 mm × 5 mm package. The thermal impedance,  $\theta_{JA}$ , is 28°C/W. It is important that the devices are not operated under conditions that cause the junction temperature to exceed its junction temperature.

Worst-case conditions occur when the AD5750 is operated from the maximum  $AV_{DD}$  (26.4 V) and driving the maximum current (24 mA) directly to ground. The quiescent current of the AD5750 should also be taken into account, nominally ~4 mA.

The following calculation estimate maximum power dissipation under these worst-case conditions, and determines maximum ambient temperature based on this:

*Power Dissipation* =  $26.4 \text{ V} \times 28 \text{ mA} = 0.7392 \text{ W}$ 

*Temp Increase* =  $28^{\circ}$ C × 0.7392 W =  $20.7^{\circ}$ C

Maximum Ambient Temp =  $125^{\circ}C - 20.7^{\circ}C = 104.3^{\circ}C$ 

These figures assume proper layout and grounding techniques are followed to minimize power dissipation, as outlined in the Layout Guidelines section.

#### LAYOUT GUIDELINES

In any circuit where accuracy is important, careful consideration of the power supply and ground return layout helps to ensure the rated performance. The PCB on which the AD5750 is mounted should be designed so that the AD5750 lies on the analog plane.

The AD5750 should have ample supply bypassing of 10  $\mu F$  in parallel with 0.1  $\mu F$  on each supply located as close to the package as possible, ideally right up against the device. The 10  $\mu F$  capacitors are the tantalum bead type. The 0.1  $\mu F$  capacitor should have low effective series resistance (ESR) and low effective series inductance (ESI) such as the common ceramic types, which provide a low impedance path to ground at high frequencies to handle transient currents due to internal logic switching.

In systems where there are many devices on one board, it is often useful to provide some heat sinking capability to allow the power to dissipate easily.

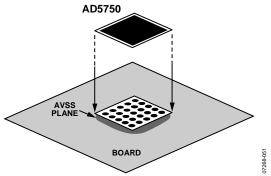


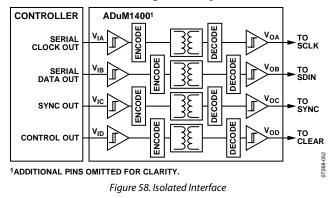
Figure 57. Paddle Connection to Board

The AD5750 has an exposed paddle beneath the device. This paddle is connected to the AVSS supply for the part. For optimum performance, special considerations should be used to design the motherboard and to mount the package. For enhanced thermal, electrical, and board level performance, the exposed paddle on the bottom of the package is soldered to the corresponding thermal land paddle on the PCB. Thermal vias are designed into the PCB land paddle area to further improve heat dissipation.

The AVSS plane on the device can be increased (as shown in Figure 57) to provide a natural heat sinking effect.

#### GALVANICALLY ISOLATED INTERFACE

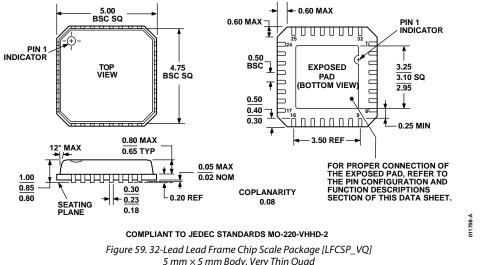
In many process control applications, it is necessary to provide an isolation barrier between the controller and the unit being controlled to protect and isolate the controlling circuitry from any hazardous common-mode voltages that may occur. The iCoupler\* family of products from Analog Devices provides voltage isolation in excess of 5.0 kV. The serial loading structure of the AD5750 makes it ideal for isolated interfaces because the number of interface lines is kept to a minimum. Figure 58 shows a 4-channel isolated interface using an ADuM1400. For further information, visit www.analog.com/icouplers.



#### MICROPROCESSOR INTERFACING

Microprocessor interfacing to the AD5750 is via a serial bus that uses a protocol compatible with microcontrollers and DSP processors. The communications channel is a 3-wire (minimum) interface consisting of a clock signal, a data signal, and a <u>SYNC</u> signal. The AD5750 require a 16-bit data-word with data valid on the falling edge of SCLK.

### **OUTLINE DIMENSIONS**



5 mm × 5 mm Body, Very Thin Quad (CP-32-2) Dimensions shown in millimeters

#### **ORDERING GUIDE**

	TUE	Analog Input	Ext	Temperature	Package	Package
Model	Accuracy	Range	Ref	Range	Description	Option
AD5750ACPZ-REEL <sup>1</sup>	±0.3%	0 V to 4.096 V	4.096 V	-40°C to +105°C	32-Lead LFCSP_VQ	CP-32-2
AD5750ACPZ-REEL71	±0.3%	0 V to 4.096 V	4.096 V	-40°C to +105°C	32-Lead LFCSP_VQ	CP-32-2
AD5750BCPZ-REEL <sup>1</sup>	±0.1%	0 V to 4.096 V	4.096 V	–40°C to +105°C	32-Lead LFCSP_VQ	CP-32-2
AD5750BCPZ-REEL71	±0.1%	0 V to 4.096 V	4.096 V	-40°C to +105°C	32-Lead LFCSP_VQ	CP-32-2

 $^{1}$  Z = RoHS Compliant Part.

### NOTES

### NOTES

### NOTES

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